## Application/Control No. Applicant(s)/Patent Under Reexamination 10/790,031 SUH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 MUHAMMAD N. EDUN 2656 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY \* US-2002/0001274 01-2002 Nakajima et al. 369/53.21 Α US-6,266,299 07-2001 Oshima et al. 369/13.38 В С US-US-D US-Ε US-F US-G US-Н US-US-J US-K US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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